Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination
10/653,350	LEE ET AL.
Examiner	Art Unit
Jegatheesan Seharaseyon, Ph.D	1647

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMF		
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